Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

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Accreditation No.: SCS 108

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Client

ADT (Auden)

Certificate No: EX3-3590 Apr09

CALIBRATION CERTIFICATE Object EX3DV4 - SN:3590 QA CAL-01.v6, QA CAL-14.v3 and QA CAL-23.v3 Calibration procedure(s) Calibration procedure for dosimetric E-field probes April 28, 2009 Calibration date: Condition of the calibrated item In Tolerance This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards D# Cal Date (Certificate No.) Scheduled Calibration Power meter E4419B GB41293874 1-Apr-09 (No. 217-01030) Apr-10 Power sensor E4412A MY41495277 1-Apr-09 (No. 217-01030) Apr-10 Power sensor E4412A MY414GROR7 1-Apr-09 (No. 217-01030) Apr-10 Reference 3 dB Attenuator SN: S5054 (3c) 31-Mar-09 (No. 217-01026) Mar-10 Reference 20 dB Attenuator SN: S5086 (20b) 31-Mar-09 (No. 217-01028) Mar-10 Reference 30 dB Attenuator SN: S5129 (30b) 31-Mar-09 (No. 217-01027) Mar-10 Reference Probe ES3DV2 2-Jan-09 (No. ES3-3013_Jan09) SN: 3013 Jan-10 DAE4 SN: 660 9-Sep-08 (No. DAE4-660_Sep08) Sep-09 Secondary Standards D# Check Date (in house) Scheduled Check RF generator HP 8648C US3642U01700 4-Aug-99 (in house check Oct-07) In house check: Oct-09 Network Analyzer HP 8753E US37390585 18-Oct-01 (in house check Oct-08) In house check: Oct-09 Name Function Signature Calibrated by: Katja Pokovic Technical Manager Approved by: Niels Kuster Quality Manager Issued: April 28, 2009

Certificate No: EX3-3590_Apr09

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This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

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Glossary:

TSL NORMx,y,z tissue simulating liquid sensitivity in free space

ConvF

sensitivity in TSL / NORMx,y,z

DCP

diode compression point

Polarization φ

φ rotation around probe axis

Polarization 9

 ϑ rotation around an axis that is in the plane normal to probe axis (at

measurement center), i.e., 9 = 0 is normal to probe axis

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization θ = 0 (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

Probe EX3DV4

SN:3590

Manufactured:
Calibrated:

March 23, 2009 April 28, 2009

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

DASY - Parameters of Probe: EX3DV4 SN:3590

Sensitivity in Free	e Space ^A		Diode C	ompression ^B	
NormX	0.49 ± 10.1%	μV/(V/m) ²	DCP X	85 mV	
NormY	0.48 ± 10.1%	$\mu V/(V/m)^2$	DCP Y	87 mV	
NormZ	0.50 ± 10.1%	μV/(V/m) ²	DCP Z	88 mV	

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

TSL

900 MHz

Typical SAR gradient: 5 % per mm

Sensor Center to	Phantom Surface Distance	2.0 mm	3.0 mm
SAR _{be} [%]	Without Correction Algorithm	9.3	5.6
SAR _{be} [%]	With Correction Algorithm	0.8	0.4

TSL

1750 MHz

Typical SAR gradient: 10 % per mm

Sensor Center t	o Phantom Surface Distance	2.0 mm	3.0 mm
SAR _{be} [%]	Without Correction Algorithm	8.0	5.0
SAR _{be} [%]	With Correction Algorithm	0.9	0.5

Sensor Offset

Probe Tip to Sensor Center

1.0 mm

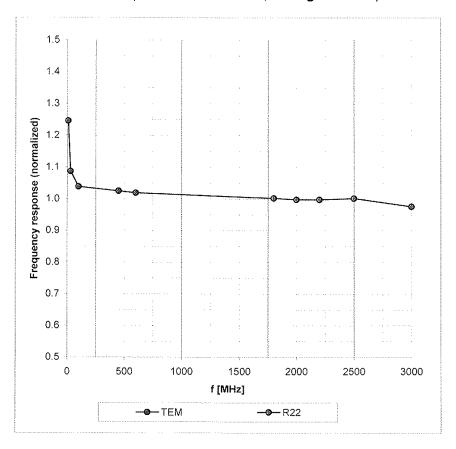
The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

 $^{^{\}rm A}$ The uncertainties of NormX,Y,Z do not affect the E $^{\rm 2}$ -field uncertainty inside TSL (see Page 8).

^B Numerical linearization parameter: uncertainty not required.

Frequency Response of E-Field

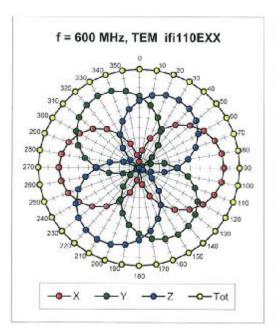
(TEM-Cell:ifi110 EXX, Waveguide: R22)

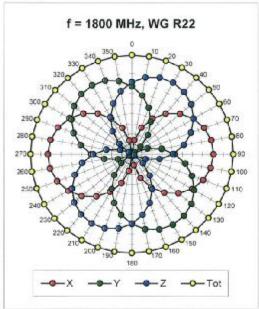


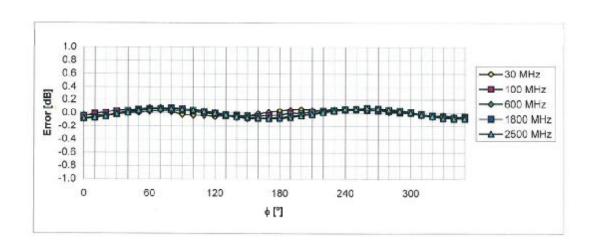
Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

Certificate No: EX3-3590_Apr09 Page 5 of 9

Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$





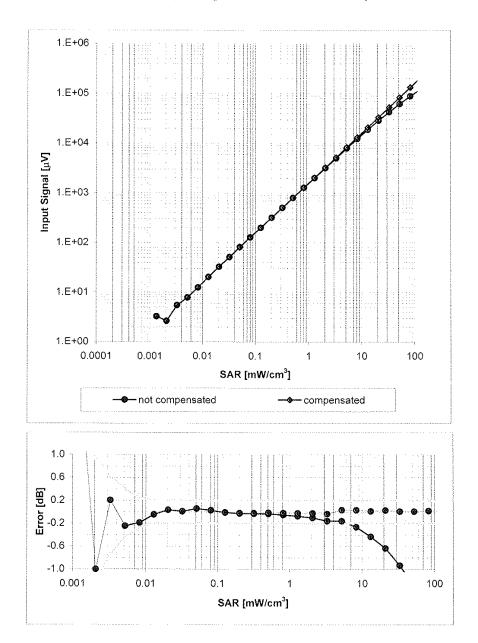


Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

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Dynamic Range f(SAR_{head})

(Waveguide R22, f = 1800 MHz)



Uncertainty of Linearity Assessment: ± 0.6% (k=2)

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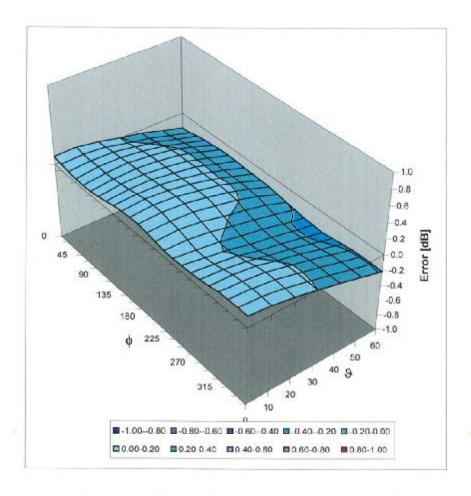
Conversion Factor Assessment

f [MHz]	Validity [MHz] ^c	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
900	± 50 / ± 100	Head	41.5 ± 5%	0.97 ± 5%	0.72	0.63	9.79 ± 11.0% (k=2)
1750	± 50 / ± 100	Head	40.1 ± 5%	1.37 ± 5%	0.70	0.58	8.82 ± 11.0% (k=2)
1950	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.63	0.61	8.39 ± 11.0% (k=2)
2300	± 50 / ± 100	Head	39.5 ± 5%	1.67 ± 5%	0.70	0.57	8.28 ± 11.0% (k=2)
2450	± 50 / ± 100	Head	39.2 ± 5%	1.80 ± 5%	0.61	0.61	7.88 ± 11.0% (k=2)
2600	± 50 / ± 100	Head	39.0 ± 5%	1.96 ± 5%	0.40	0.76	7.85 ± 11.0% (k=2)
3500	± 50 / ± 100	Head	37.9 ± 5%	2.91 ± 5%	0.33	1.10	7.15 ± 13.1% (k=2)
4950	± 50 / ± 100	Head	36.3 ± 5%	4.40 ± 5%	0.42	1.70	5.43 ± 13.1% (k=2)
5200	± 50 / ± 100	Head	$36.0 \pm 5\%$	4.66 ± 5%	0.45	1.70	5.34 ± 13.1% (k=2)
5300	± 50 / ± 100	Head	35.9 ± 5%	4.76 ± 5%	0.45	1.70	4.90 ± 13.1% (k=2)
5500	± 50 / ± 100	Head	35.6 ± 5%	4.96 ± 5%	0.50	1.70	4.79 ± 13.1% (k=2)
5600	± 50 / ± 100	Head	35.5 ± 5%	5.07 ± 5%	0.50	1.70	4.61 ± 13.1% (k=2)
5800	± 50 / ± 100	Head	35.3 ± 5%	5.27 ± 5%	0.50	1.70	4.60 ± 13.1% (k=2)
900	± 50 / ± 100	Body	55.0 ± 5%	1.05 ± 5%	0.49	0.74	9.93 ± 11.0% (k=2)
1750	± 50 / ± 100	Body	53.4 ± 5%	1.49 ± 5%	0.59	0.68	8.62 ± 11.0% (k=2)
1950	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.47	0.77	8.39 ± 11.0% (k=2)
2300	± 50 / ± 100	Body	52.8 ± 5%	1.85 ± 5%	0.38	0.86	8.05 ± 11.0% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.40	0.77	7.96 ± 11.0% (k=2)
2600	± 50 / ± 100	Body	52.5 ± 5%	2.16 ± 5%	0.34	0.86	7.84 ± 11.0% (k=2)
3500	± 50 / ± 100	Body	51.3 ± 5%	3.31 ± 5%	0.33	1.26	6.75 ± 13.1% (k=2)
4950	± 50 / ± 100	Body	49.4 ± 5%	5.01 ± 5%	0.40	1.80	5.13 ± 13.1% (k=2)
5200	± 50 / ± 100	Body	49.0 ± 5%	5.30 ± 5%	0.50	1.80	5.01 ± 13.1% (k=2)
5300	± 50 / ± 100	Body	48.5 ± 5%	5.42 ± 5%	0.50	1.80	4.72 ± 13.1% (k=2)
5500	± 50 / ± 100	Body	48.6 ± 5%	5.65 ± 5%	0.56	1.80	4.42 ± 13.1% (k=2)
5600	± 50 / ± 100	Body	48.5 ± 5%	5.77 ± 5%	0.55	1.80	4.07 ± 13.1% (k=2)
5800	± 50 / ± 100	Body	48.2 ± 5%	6.00 ± 5%	0.60	1.80	4.62 ± 13.1% (k=2)

 $^{^{\}rm C}$ The validity of \pm 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

Deviation from Isotropy in HSL

Error (6, 9), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)



D3: DAE

Zeughausstrasse 43, 8004 Zurich, Switzerland Phone +41 44 245 9700, Fax +41 44 245 9779 info@speag.com, http://www.speag.com

IMPORTANT NOTICE

USAGE OF THE DAE 3

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points:

Battery Exchange: The battery cover of the DAE3 unit is connected to a fragile 3-pin battery connector. Customer is responsible to apply outmost caution not to bend or damage the connector when changing batteries.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration the customer shall remove the batteries and pack the DAE in an antistatic bag. This antistatic bag shall then be packed into a larger box or container which protects the DAE from impacts transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures. Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, Customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the annual calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the Estop assembly is allowed by certified SPEAG personnel only and is part of the annual calibration procedure.

Important Note:

To prevent damage of the DAE probe connector pins, use great care when installing the probe to the DAE. Carefully connect the probe with the connector notch oriented in the mating position. Avoid any rotational movement of the probe body versus the DAE while turning the locking nut of the connector. The same care shall be used when disconnecting the probe from the DAE.

Schmid & Partner Engineering

TN_BR03091211BC DAE3.doc

23.10.2008

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Client

ADT (Auden)

Certificate No: DAE3-510_Jan09

Accreditation No.: SCS 108

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Object	DAE3 - SD 000 D0	03 AA - SN: 510			
Calibration procedure(s)	QA CAL-06.v12 Calibration procedure for the data acquisition electronics (DAE)				
Calibration date:	January 21, 2009				
Condition of the calibrated item	In Tolerance				
The measurements and the uncer	tainties with confidence pro	bability are given on the following pages	s and are part of the certificate.		
All calibrations have been conduct Calibration Equipment used (M&T		facility: environment temperature (22 ± Cal Date (Certificate No.)	3)°C and humidity < 70%. Scheduled Calibration		
Calibration Equipment used (M&T	E critical for calibration)	Cal Date (Certificate No.) 30-Sep-08 (No: 7673)	Scheduled Calibration Sep-09		
Calibration Equipment used (M&T Primary Standards Fluke Process Calibrator Type 70:	E critical for calibration)	Cal Date (Certificate No.)	Scheduled Calibration		
Calibration Equipment used (M&T Primary Standards Fluke Process Calibrator Type 703 Keithley Multimeter Type 2001	E critical for calibration) ID # SN: 6295803 SN: 0810278	Cal Date (Certificate No.) 30-Sep-06 (No: 7673) 30-Sep-08 (No: 7670)	Scheduled Calibration Sep-09		
Calibration Equipment used (M&T Primary Standards Fluke Process Calibrator Type 70:	E critical for calibration) ID # SN: 6295803 SN: 0810278	Cal Date (Certificate No.) 30-Sep-08 (No: 7673)	Scheduled Calibration Sep-09 Sep-09		
Calibration Equipment used (M&T Primary Standards Fluke Process Calibrator Type 703 Keithley Multimeter Type 2001 Secondary Standards	E critical for calibration) ID # SN: 6295803 SN: 0810278 ID # SE UMS 006 AB 1004	Cal Date (Certificate No.) 30-Sep-08 (No: 7673) 30-Sep-08 (No: 7670) Check Date (In house) 06-Jun-08 (in house check)	Scheduled Calibration Sep-09 Sep-09 Scheduled Check		
Calibration Equipment used (M&T Primary Standards Fluke Process Calibrator Type 703 Keithley Multimeter Type 2001 Secondary Standards	E critical for calibration) ID # SN: 6295803 SN: 0810278	Cal Date (Certificate No.) 30-Sep-08 (No: 7673) 30-Sep-08 (No: 7670) Check Date (In house)	Scheduled Calibration Sep-09 Sep-09 Scheduled Check In house check: Jun-09		
Calibration Equipment used (M&T Primary Standards Fluke Process Calibrator Type 703 Ceithley Multimeter Type 2001 Secondary Standards Calibrator Box V1.1	E critical for calibration) ID # 2 SN: 6295803 SN: 0810278 ID # SE UMS 006 AB 1004 Name	Cal Date (Certificate No.) 30-Sep-08 (No: 7673) 30-Sep-08 (No: 7670) Check Date (In house) 06-Jun-08 (in house check)	Scheduled Calibration Sep-09 Sep-09 Scheduled Check In house check: Jun-09		

Certificate No: DAE3-510_Jan09

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Glossary

DAE data acquisition electronics

Connector angle information used in DASY system to align probe sensor X to the robot

coordinate system.

Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
 - Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
 - Input Offset Measurement: Output voltage and statistical results over a large number of zero voltage measurements.
 - Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - Input resistance: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - Power consumption: Typical value for information. Supply currents in various operating modes.

Certificate No: DAE3-510_Jan09 Page 2 of 5

DC Voltage Measurement

A/D - Converter Resolution nominal

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	x	Y	Z
High Range	404.180 ± 0.1% (k=2)	404.237 ± 0.1% (k=2)	404.597 ± 0.1% (k=2)
Low Range	3.98584 ± 0.7% (k=2)	3.96418 ± 0.7% (k=2)	3.97982 ± 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	42°±1°

Certificate No: DAE3-510_Jan09 Page 3 of 5

Appendix

1. DC Voltage Linearity

High Range		Input (μV)	Reading (μV)	Error (%)
Channel X	+ Input	200000	200000.4	0.00
Channel X	+ Input	20000	20006.50	0.03
Channel X	- Input	20000	-20001.19	0.01
Channel Y	+ Input	200000	200000	0.00
Channel Y	+ Input	20000	20006.34	0.03
Channel Y	- Input	20000	-19999.47	0.00
Channel Z	+ Input	200000	200000.4	0.00
Channel Z	+ Input	20000	20005.85	0.03
Channel Z	- Input	20000	-20001.94	0.01

Low Range		Input (μV)	Reading (μV)	Error (%)
Channel X	+ Input	2000	2000.1	0.00
Channel X	+ Input	200	200.26	0.13
Channel X	- Input	200	-200.29	0.14
Channel Y	+ Input	2000	1999.9	0.00
Channel Y	+ Input	200	199.55	-0.22
Channel Y	- Input	200	-200.78	0.39
Channel Z	+ input	2000	2000	0.00
Channel Z	+ Input	200	199.35	-0.32
Channel Z	- Input	200	-200.86	0.43

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	17.77	16.87
	- 200	-15.55	-16.83
Channel Y	200	16.07	14.66
	- 200	-15.10	-16.55
Channel Z	200	-7.41	-8.67
	- 200	8.31	7.63

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	2.33	0.92
Channel Y	200	0.91	-	2.64
Channel Z	200	-1.49	0.24	_

Certificate No: DAE3-510_Jan09

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15922	16220
Channel Y	16083	15853
Channel Z	16077	16696

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input $10M\Omega$

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (μV)
Channel X	0.06	-0.34	0.80	0.21
Channel Y	-1.04	-1.65	0.01	0.25
Channel Z	0.59	-0.07	2.82	0.30

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.2001	199.1
Channel Y	0.2001	197.8
Channel Z	0.2001	199.1

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)	
Supply (+ Vcc)	+7.9	
Supply (- Vcc)	-7.6	

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	0.01	-8	- 9

Certificate No: DAE3-510_Jan09

Zeughausstrasse 43, 8004 Zurich, Switzerland Phone +41 44 245 9700, Fax +41 44 245 9779 info@speag.com, http://www.speag.com

IMPORTANT NOTICE

USAGE OF THE DAE 4

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points:

Battery Exchange: The battery cover of the DAE4 unit closed using a screw, over tightening the screw may cause the threads inside the DAE to wear out.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration Customer shall remove the batteries and pack the DAE in an antistatic bag. The packaging shall protect the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, Customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the annual calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the Estop assembly is allowed by certified SPEAG personnel only and is part of the annual calibration procedure.

Schmid & Partner Engineering

TN_BR040315AB DAE4.doc

24.04.2007

Calibration Laboratory of Schmid & Partner **Engineering AG** Zeughausstrasse 43, 8004 Zurich, Switzerland





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Client

Jabil Circuits (Auden)

Accreditation No.: SCS 108

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Certificate No: DAE4-861_Sep08 CALIBRATION CERTIFICATE DAE4 - SD 000 D04 BG - SN: 861 Object QA CAL-06.v12 Calibration procedure(s) Calibration procedure for the data acquisition electronics (DAE) September 22, 2008 Calibration date: In Tolerance Condition of the calibrated item This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Scheduled Calibration Primary Standards Cal Date (Certificate No.) Oct-08 Fluke Process Calibrator Type 702 SN: 6295803 04-Oct-07 (No: 6467) Oct-08 Keithley Multimeter Type 2001 SN: 0810278 03-Oct-07 (No: 6465) Scheduled Check Secondary Standards Check Date (in house) SE UMS 008 AB 1004 06-Jun-08 (in house check) In house check: Jun-09 Calibrator Box V1.1 Function Andrea Guntil Technician Calibrated by: Fin Bomholt R&D Director Approved by: Issued: September 25, 2008 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

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Accreditation No.: SCS 108

Glossary

DAE

data acquisition electronics

Connector angle

information used in DASY system to align probe sensor X to the robot

coordinate system.

Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
 - Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
 - Input Offset Measurement: Output voltage and statistical results over a large number of zero voltage measurements.
 - Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - Input resistance: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - Power consumption: Typical value for information. Supply currents in various operating modes.

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DC Voltage Measurement

A/D - Converter Resolution nominal

Calibration Factors	X	Υ	Z
High Range	404.365 ± 0.1% (k=2)	404.742 ± 0.1% (k=2)	405.670 ± 0.1% (k=2)
Low Range	4.02029 ± 0.7% (k=2)	3.98762 ± 0.7% (k=2)	4.01204 ± 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	124 ° ± 1 °
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Appendix

1. DC Voltage Linearity

High Range		Input (μV)	Reading (μV)	Error (%)
Channel X	+ Input	200000	199999.9	0.00
Channel X	+ Input	20000	20002.71	0.01
Channel X	- Input	20000	-20003.54	0.02
Channel Y	+ Input	200000	200000.3	0.00
Channel Y	+ Input	20000	19999.17	0.00
Channel Y	- Input	20000	-20003.37	0.02
Channel Z	+ Input	200000	199999.8	0.00
Channel Z	+ Input	20000	20000.36	0.00
Channel Z	- Input	20000	-20005.96	0.03

Low Range	Input (μV)	Reading (μV)	Error (%)
Channel X + Input	2000	2000	0.00
Channel X + Input	200	199.92	-0.04
Channel X - Input	200	-200.25	0.13
Channel Y + Input	2000	1999.9	0.00
Channel Y + Input	200	199.32	-0.34
Channel Y - Input	200	-200.67	0.33
Channel Z + Input	2000	2000	0.00
Channel Z + Input	200	199.65	-0.18
Channel Z - Input	200	-201.81	0.91

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	5.10	4.08
	- 200	-4.32	-4.27
Channel Y	200	1.83	1.39
	- 200	-2.21	-3.06
Channel Z	200	-10.14	-10.20
	- 200	8.87	7.81

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	3.33	0.83
Channel Y	200	0.10	-	4.12
Channel Z	200	-0.22	0.96	-

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15980	15973
Channel Y	16090	15869
Channel Z	16031	16364

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10MΩ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (μV)
Channel X	-0.05	-2.16	1.46	0.57
Channel Y	-0.73	-2.87	1.71	0.55
Channel Z	-1.37	-4.32	0.61	0.75

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.1999	197.8
Channel Y	0.2000	200.0
Channel Z	0.1999	198.0

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)	
Supply (+ Vcc)	+7.9	
Supply (- Vcc)	-7.6	

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9

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